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Optical energy optimization at the nanoscale by near-field interference

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Employing plasmonic antennas for subdiffraction focusing of light on recording media requires to take into account the complete structure of the medium, including dielectric cover layers. We find, with Finite Difference Time Domain simulations, that optical energy transfer to the magnetic recording layer is most efficient for an off-resonant antenna. Furthermore we show that the focal spot in the magnetic film is well below the diffraction limit, making nanoscale all-optical magnetic data recording achievable.

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Due to their ability to confine light below the diffraction limit and the accompanying large intensity enhancement¹⁻⁵, optical antennas are ideal for increasing the efficiency of light-matter interactions. These properties make optical antennas not only useful for applications in the field of photovoltaics, nonlinear optics, and quantum optics⁶, but also in data storage technologies.

In Heat Assisted Magnetic Recording (HAMR), plasmonic structures are used to heat nanoscale spots, such that their magnetization can then be reversed with a smaller magnetic field, increasing the potential data storage density^{7,8}. With HAMR an external magnetic field is still necessary. However, exploiting helicity dependent all-optical switching (HD-AOS) magnetic domains can be switched reversibly with circularly polarized femtosecond laser pulses in the absence of any external magnetic field, making all-optical data storage and retrieval possible⁹⁻¹¹.

Although the HD-AOS process is very fast, the reported sizes of the switched domains are of several microns, which is not appealing for industry, where the actual bit size is already well below 100 nm. The plasmonic structures used in HAMR can however not be implemented for HD-AOS as they do not preserve the light polarization. To maintain the circular polarization state in the near field we will make use of cross antennas. With this type of antennas large enhancement factors have been demonstrated in the antenna gap^{12,13}. However, as the actual recording media are usually protected by a dielectric or metallic capping layer of several tens of nanometers, this will severely affect the focusing abilities and subsequent potential data densities for HD-AOS .

Here we demonstrate that it is possible to deliver energy to the magnetic layer more efficiently by exploiting the near-field interference between the excitation light and the re-emitted light¹⁴. In particular we show that due to this interference an off-resonant antenna delivers more energy to a distant plane as compared to a resonant one. Evaluating the spot size and field enhancement that can be obtained inside the magnetic film shows that we have a gain in energy together with a sub-diffraction sized spot, even in the presence of a capping layer. These two quantities are of direct relevance for HD-AOS .

The structure we consider is as follows: a glass substrate (dielectric constant¹⁵ $\epsilon = 2.11$)¹⁶, a thin film of magnetic material, in our case 20 nm of GdFeCo ($\epsilon = -1.15 + 28.56i$)¹⁷, protected by a capping layer of Si₃N₄ ($\epsilon = 4$)¹⁶. The sample is similar to the samples typically used in HD-AOS experiments^{10,11}. In those experiments a capping layer of 60 nm is used

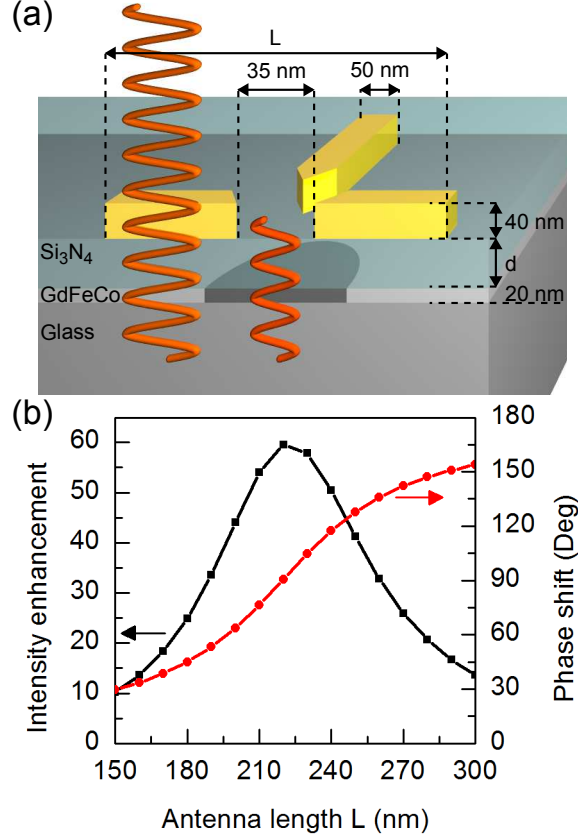


FIG. 1. Crossed dipole antenna. (a) A sketch of the considered situation. An incoming wave(left) excites the antenna and interferes with the re-emitted wave(right). In the GdFeCo layer this results in a nanoscale reversed magnetic domain(dark cylinder) due to HD-AOS. (b) Intensity enhancement and phase shift as a function of the antenna length. Both are recorded in the center of the antenna gap and in the presence of a 60 nm Si_3N_4 layer.

to optimize the magneto-optical signal. On top of the last layer we place the cross antenna structure. We use Finite Difference Time Domain (FDTD) simulations¹⁸ to calculate the electromagnetic (EM) fields at different positions in the structure presented in Fig. 1(a). A circularly polarized plane wave at a wavelength of 800 nm is used to excite the antenna. In the simulations we assume typical dimensions for real cross antennas: a thickness of 40 nm, an arm width of 50 nm, and a gap size of 35 nm¹⁹. The total length of two opposite arms including the gap is varied from 110 nm to 300 nm. The antenna is made of gold ($\epsilon = -24.11 + 1.49i$)²⁰. In the FDTD simulations a non-uniform meshing is used with the smallest mesh cells $1 \times 1 \times 1$ nm at the position of the antenna, extending to the GdFeCo film directly underneath the antenna.

In general, when plasmonic antennas are considered, the attention is focused on the intensity enhancement. This intensity enhancement is calculated by normalizing the field intensities obtained in the presence of the antenna structure with the results of a simulation without the antenna. Fig. 1(b) shows this intensity enhancement in the antenna gap when the antenna length is varied and a 60 nm thick Si_3N_4 capping layer is used. However, the intensity enhancement as defined earlier does not take into account the difference in energy delivery to the magnetic thin film due to a change in the capping layer thickness, while this capping layer, which is effectively a cavity, will influence the energy delivery. As HD-AOS depends on the polarization of the EM fields we would like to have a measure for the degree of circular polarization as well. For these reasons we will from here on use the following figure of merit (FOM)^{12,13} defined by

$$\text{FOM} = IC^2, \quad (1)$$

where I is the intensity and C is the degree of circular polarization given by

$$C = \frac{2E_x E_y \sin(\delta_x - \delta_y)}{I}. \quad (2)$$

Here E_i and δ_i are respectively the amplitude and phase of the field component i . For I we will take the field intensity normalized to the source intensity. Note that the source intensity is equal for all simulations and thus it will take into account the difference in energy delivery due to the capping layer thickness. We would like to emphasize that we do not use the intensity enhancement here, which we can get if we normalize to the intensity profile obtained without antenna in the same plane.

In Fig. 2 the FOM inside the GdFeCo is shown as a function of the capping layer thickness and the antenna length. Two maxima can be observed, the first maximum can be found for a dielectric layer thickness of 10 nm and an antenna length of 210 nm. The second maximum is reached for a capping layer thickness of 60 nm and an antenna length of 190 nm. For both capping layer thicknesses this maximum does not coincide with the antenna resonant length as defined in the antenna gap and indicated by the black dots in Fig. 2. Note that when the capping layer thickness is changed the antenna resonant length and quality can be different as well. Close to the metallic magnetic film the FOM inside the antenna gap will be reduced significantly due to the presence of an extra loss channel formed by the lossy plasmon modes bound to the GdFeCo surface. This directly explains the equal amplitude of the two maxima despite the difference in distance.

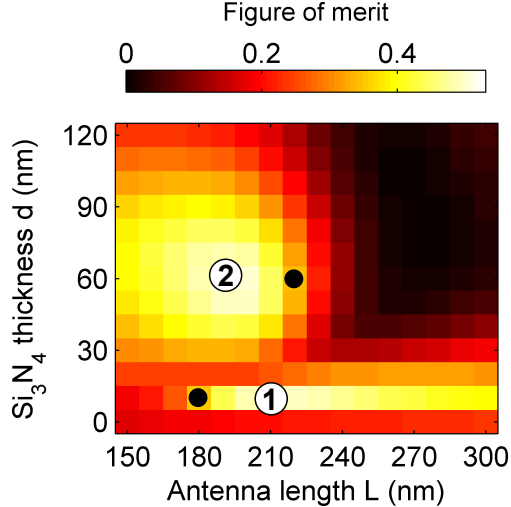


FIG. 2. FOM as function of the antenna length L and the Si_3N_4 layer thickness d . The FOM is recorded at half-height of the GdFeCo layer directly below the center of the antenna. Two maxima are observed, indicated by the numbers one and two. The black dots indicate the lengths at which the antenna is resonant for the two optimal Si_3N_4 thicknesses.

To explain the origin of the discrepancy between the antenna lengths at which the FOM in the GdFeCo reaches a maximum and the antenna resonant length, we will concentrate on the capping layer thicknesses at which these maxima occur. In Fig. 3 the FOM inside the GdFeCo (open symbols) is shown together with the FOM in the center of the antenna gap (solid symbols) at a fixed Si_3N_4 thickness of 60 nm(a) and 10 nm(b). These figures show a clear difference between the behavior of the FOM with antenna length in the plane of the antenna and inside the GdFeCo. The maximum intensity in the GdFeCo layer occurs for 10 nm (60 nm) of Si_3N_4 for an antenna longer (shorter) than the resonant length.

The observed behavior can be explained by interference between the re-emitted light from the antenna and the excitation light. Like a harmonic oscillator, a resonance in intensity goes together with a phase shift for the re-emitted light. The phase shift in the center of the antenna gap as function of the antenna length is shown in Fig. 1(b) for the 60 nm thick capping layer. In the center of the antenna gap no interference can be observed due to the large difference in intensity of the two light sources. From Fig. 1(b) it can be seen that the light in the antenna gap is 60 times more intense than the exciting light. However, the exponential decay of the plasmon fields causes this large difference in intensity to disappear fast with distance. This results in comparable intensities for the two light beams in the

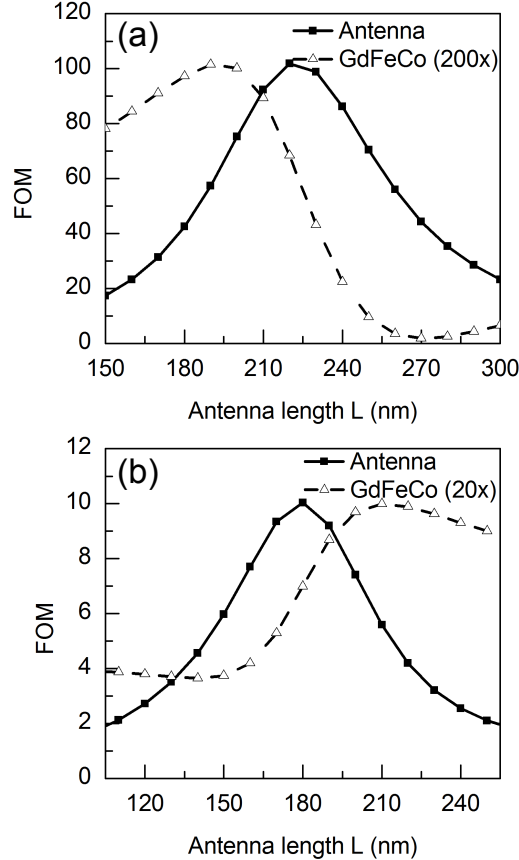


FIG. 3. FOM in the GdFeCo (open symbols) as function of antenna length. The solid symbols show the FOM in the center of the antenna gap. In (a) a 60 nm Si_3N_4 layer is present while in (b) this layer is 10 nm thick.

GdFeCo layer, 60 nm below the antenna, leading to interference effects. The increase in intensity towards the plasmon resonance combined with the relative small phase difference for antennas shorter than the resonant length makes the maximum intensity in the active layer to occur for an antenna that is a few tens of nanometers shorter than a resonant antenna. For antennas longer than resonant ones, the large phase shift for the re-emitted light results in destructive interference, which explains the minimum in Fig. 3(a) for an antenna length of 270 nm.

If we now compare the above situation with the case of only a 10 nm capping layer, Fig. 3(b), then we can observe a few differences. First, in Fig. 3(b) there is no complete destructive interference visible. This could indicate that the two EM waves that interfere do not have the same amplitude. The other difference is that while in the 60 nm case we

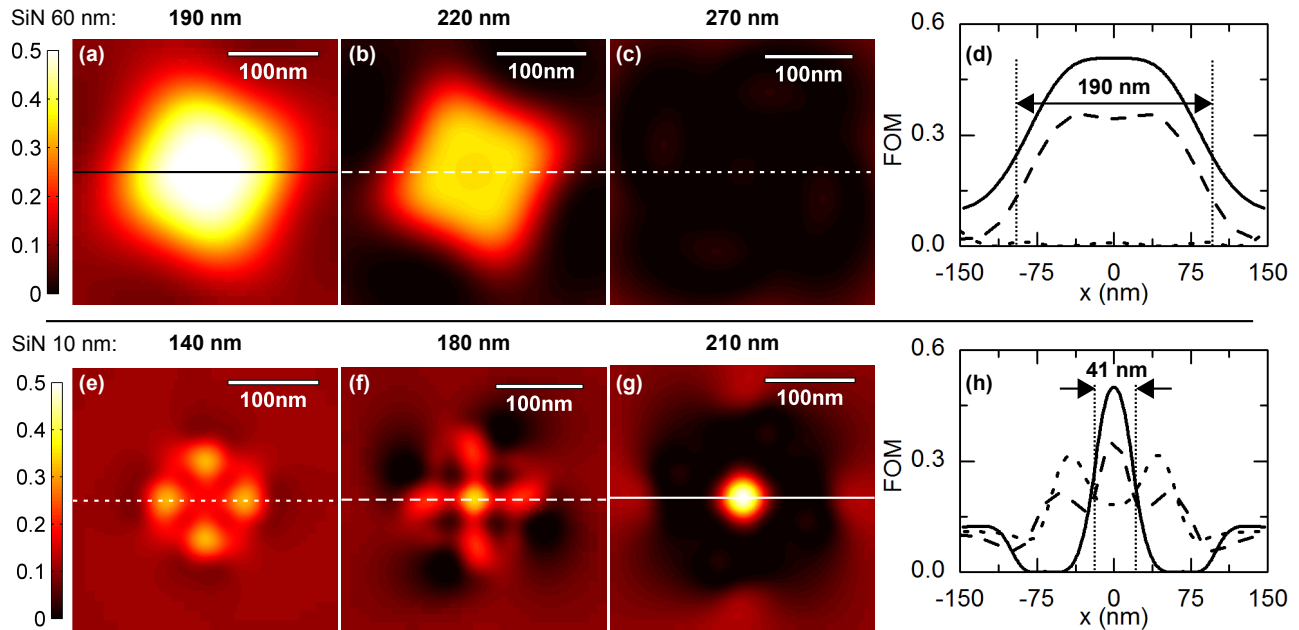


FIG. 4. FOM distribution in a 2D plane at half height of the GdFeCo layer in case of a 60 nm (a)-(c) and a 10 nm (e)-(g) dielectric layer for different antenna lengths. In (d) and (h) cross-sections through the center of respectively (a)-(c) and (e)-(g) are shown. The FWHM of the central spot is indicated for the cross-section of 190 nm (d) and 210 nm (h) antenna length.

have a maximum for an antenna that is shorter than the resonant one, for the 10 nm case we have in the same situation a minimum. We ascribe this effective phase shift of roughly π for one of the two waves to the interplay between the plasmon modes of the antenna and the GdFeCo film.

All previous simulation results were collected in a single point only. However, for the purpose of magnetic switching it is interesting to know the field patterns resulting from the interference in the plane of the magnetic thin film. These interference patterns give an indication about the size of the magnetic domain that is switched by using the optical antennas as considered in this paper. The obtained interference patterns for the 60 nm thick capping layer are shown in Figs. 4(a)-(c) for antenna lengths of respectively 190 nm (constructive interference), 220 nm (plasmon resonance) and 270 nm (destructive interference). For the antenna with a length of 190 nm a spot size with a full width at half maximum (FWHM) of 190 nm is found, as is clearly shown in Fig. 4(d). Note that we have a constant FOM over a width of 90 nm. If we calculate the maximum intensity enhancement in the GdFeCo for this antenna we find a value of 2.6.

Figs. 4(e)-(h) shows the same information as Figs. 4(a)-(d) but now for a 10 nm capping layer. With this thickness we find an even smaller spot size with a FWHM of 41 nm. This sub diffraction area is substantially smaller than the spot size of a light beam focused with conventional objectives (typical dimensions with an immersion oil objective are of approximately 350 nm using 800 nm light). We would like to mention that considering only the field intensity I would give a spot size FWHM of 52 nm. Hence we have here an advantage due to the dependence of the AOS on the helicity of light. The maximum field enhancement in the 41 nm spot is 3.7. This would mean that the known switching threshold of 2.6 mJ/cm² for a GdFeCo sample without any structure on top²¹, will reduce to 0.7 mJ/cm² in the case that nanoantennas are used.

Although low, the intensity enhancement we find is in the same order of magnitude of others reported for devices aimed for similar applications (as for example reported in Fig. 2(b) of Ref. 7). In our case the low value is caused by the quickly vanishing nature of the near fields together with the presence of a capping layer while for example in Ref. 7 there is a less efficient coupling due to the high refractive index surrounding the antenna. For the purpose of HD-AOS this small enhancement factor is not a problem as the main reason to use optical antennas here is to bring down switching to the nanoscale.

In this paper we considered a plasmonic structure that can be made with the current state of the art nanofabrication technologies¹⁹. With progress in the fabrication process smaller antenna gaps will be attainable. This would make it possible to have smaller spot sizes and larger enhancement factors. Considering data storage technology, in which a writing head (antenna) moves over the medium, we performed some simulations with a 7 nm air slit between the antenna and the capping layer as well. Except in the antenna length no noticeable changes were observed.

To conclude, we have shown that besides the direct field enhancement and field confinement related to plasmonic structures, near-field interference effects can be of similar importance when optimizing the energy delivery to the near field. As a relevant example we considered a metallic magnetic thin film protected by a dielectric capping layer with cross-antennas on top. The antenna length at which the maximum energy is delivered to the thin film differs from the resonant antenna length. This difference can be attributed to the interference between the excitation light and the re-emitted light by the antenna. With the antennas on top of a 10 nm thick capping layer and using 800 nm light, we were able to

obtain a sub diffraction spot with a maximum intensity enhancement of 3.7 and a FWHM of 41 nm inside the magnetic material, which is comparable to the bit size in present day storage technology.

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